

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEENAU ET AL.	
		10/708,825	Examiner	Art Unit Daniel I. Walsh

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	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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